Notice of References Cited Application/Control No. 10/501,047 Examiner Khanh T. Nguyen Applicant(s)/Patent Under Reexamination BUCHE ET AL. Page 1 of 1

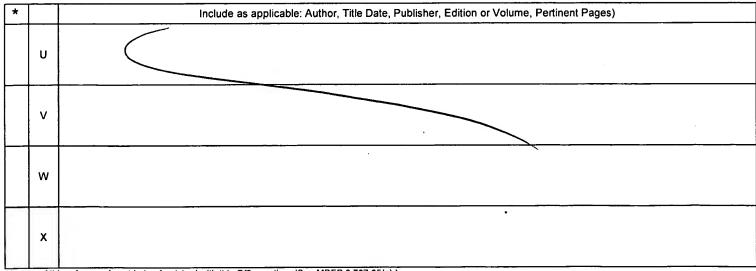
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,528,201	03-2003	Hitomi, Shuji	429/42
*	В	US-5,441,822	08-1995	Yamashita et al.	429/34
*	С	US-6,156,451	12-2000	Banerjee et al.	156/228
*	D	US-7,147,957	12-2006	Hitomi, Shuji	429/40
*	E	US-6,764,624	07-2004	Saito et al.	264/115
*	F	US-6,667,268	12-2003	Sugawara et al.	502/101
*	G	US-6,528,201	03-2003	Hitomi, Shuji	429/42
*	Н	US-6,156,451	12-2000	Banerjee et al.	156/228
*	1	US-5,441,822	08-1995	Yamashita et al.	429/34
		US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 4417403 A1	11-1994	Germany	NAKAMATSU et al.	
	0					
	Р					
	Q		<u> </u>			
	R					
	S					
	Т					

NON-PATENT DOCUMENTS



*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.